

# IRFS11N50APbF

HEXFET® Power MOSFET

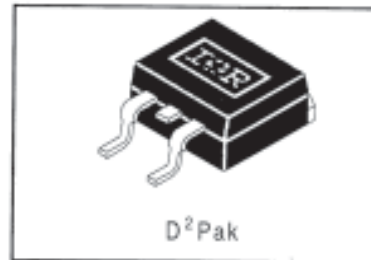
### Applications

- Switch Mode Power Supply ( SMPS )
- Uninterruptable Power Supply
- High speed power switching
- Lead-Free

### Benefits

- Low Gate Charge Qg results in Simple Drive Requirement
- Improved Gate, Avalanche and dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified ( See AN 1001)

| V <sub>DSS</sub> | R <sub>ds(on)</sub> max | I <sub>D</sub> |
|------------------|-------------------------|----------------|
| 500V             | 0.52Ω                   | 11A            |



### Absolute Maximum Ratings

|   | Parameter  | Max.                   | Units |
|---|--|------------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10VⓈ | 11                     | A     |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10VⓈ | 7.0                    |       |
| I <sub>DM</sub>                         | Pulsed Drain Current ⓈⓈ                          | 44                     |       |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C  | Power Dissipation                                | 170                    | W     |
|   | Linear Derating Factor                           | 1.3                    | W/°C  |
| V <sub>GS</sub>                         | Gate-to-Source Voltage                           | ± 30                   | V     |
| dv/dt                                   | Peak Diode Recovery dv/dt ⓈⓈ                     | 6.9                    | V/ns  |
| T <sub>J</sub>                          | Operating Junction and                           | -55 to + 150           | °C    |
| T <sub>STG</sub>                        | Storage Temperature Range                        |                        |       |
|   | Soldering Temperature, for 10 seconds            | 300 (1.6mm from case ) |       |

### Applicable Off Line SMPS Topologies:

- Two Transistor Forward
- Half & Full Bridge
- Power Factor Correction Boost

Notes Ⓢ through Ⓢ are on page 8

# IRFS11N50APbF

International  
IR Rectifier

## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max. | Units    | Conditions  |
|---------------------------------|--------------------------------------|------|-------|------|----------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 500  | —     | —    | V        | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.060 | —    | V/°C     | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ Ⓞ   |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.52 | $\Omega$ | $V_{GS} = 10V, I_D = 6.6A$ Ⓞ                          |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 25   | $\mu A$  | $V_{DS} = 500V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —     | 250  |          | $V_{DS} = 400V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100  | nA       | $V_{GS} = 30V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100 |          | $V_{GS} = -30V$                                       |

## Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                       | Parameter                       | Min. | Typ. | Max. | Units | Conditions                                      |
|-----------------------|---------------------------------|------|------|------|-------|---|
| $g_{fs}$              | Forward Transconductance        | 6.1  | —    | —    | S     | $V_{DS} = 50V, I_D = 6.6A$ Ⓞ                    |
| $Q_g$                 | Total Gate Charge               | —    | —    | 52   | nC    | $I_D = 11A$                                     |
| $Q_{gs}$              | Gate-to-Source Charge           | —    | —    | 13   |       | $V_{DS} = 400V$                                 |
| $Q_{gd}$              | Gate-to-Drain ("Miller") Charge | —    | —    | 18   |       | $V_{GS} = 10V$ , See Fig. 6 and 13 ⓄⓄ           |
| $t_{d(on)}$           | Turn-On Delay Time              | —    | 14   | —    | ns    | $V_{DS} = 250V$                                 |
| $t_r$                 | Rise Time                       | —    | 35   | —    |       | $I_D = 11A$                                     |
| $t_{d(off)}$          | Turn-Off Delay Time             | —    | 32   | —    |       | $R_G = 9.1\Omega$                               |
| $t_f$                 | Fall Time                       | —    | 28   | —    |       | $R_D = 22\Omega$ , See Fig. 10 ⓄⓄ               |
| $C_{iss}$             | Input Capacitance               | —    | 1423 | —    | pF    | $V_{GS} = 0V$                                   |
| $C_{oss}$             | Output Capacitance              | —    | 208  | —    |       | $V_{DS} = 25V$                                  |
| $C_{riss}$            | Reverse Transfer Capacitance    | —    | 8.1  | —    |       | $f = 1.0\text{MHz}$ , See Fig. 5Ⓞ               |
| $C_{oss1}$            | Output Capacitance              | —    | 2000 | —    |       | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$ |
| $C_{oss2}$            | Output Capacitance              | —    | 55   | —    |       | $V_{GS} = 0V, V_{DS} = 400V, f = 1.0\text{MHz}$ |
| $C_{oss\text{ eff.}}$ | Effective Output Capacitance    | —    | 97   | —    |       | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$ ⓄⓄ  |


## Avalanche Characteristics

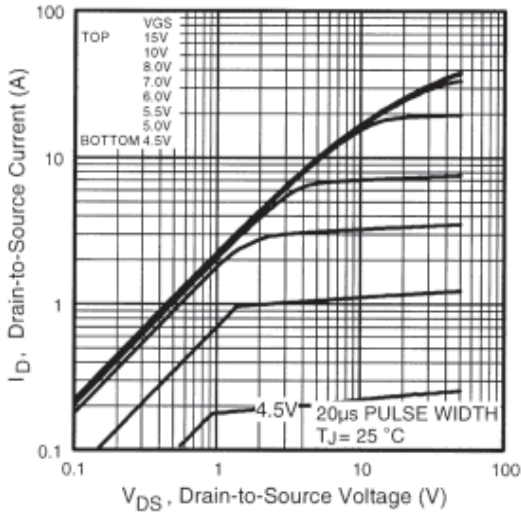
|          | Parameter                       | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche EnergyⓄⓄ | —    | 275  | mJ    |
| $I_{AR}$ | Avalanche CurrentⓄ              | —    | 11   | A     |
| $E_{AR}$ | Repetitive Avalanche EnergyⓄ    | —    | 17   | mJ    |

## Thermal Resistance

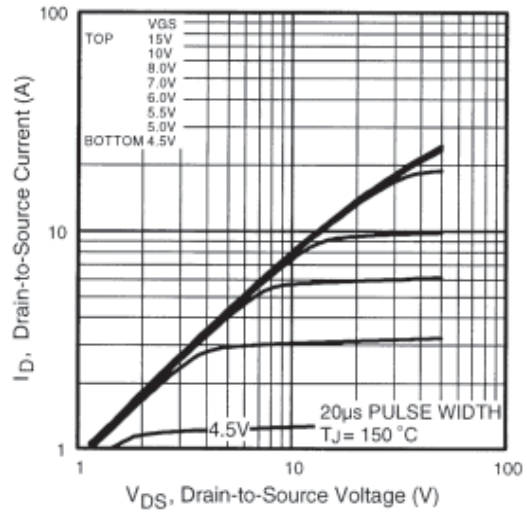
|                 | Parameter                           | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | 0.75 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | 62   |       |

## Diode Characteristics

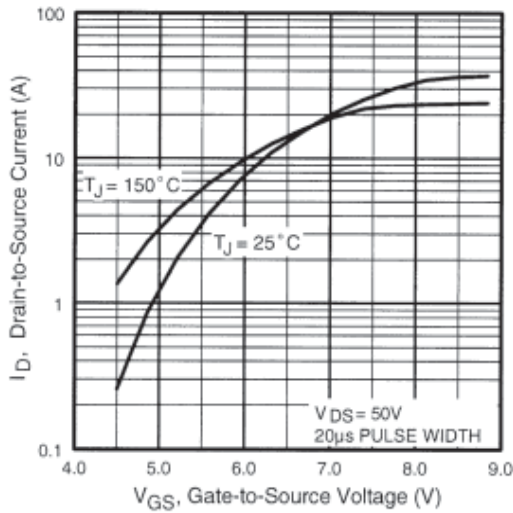
|          | Parameter                              | Min.  | Typ. | Max. | Units   | Conditions   |
|----------|--|---|------|------|---------|--|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 11   | A       | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) Ⓞ   | —   | —    | 44   |         |  |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 1.5  | V       | $T_J = 25^\circ\text{C}, I_S = 11A, V_{GS} = 0V$ Ⓞ   |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 510  | 770  | ns      | $T_J = 25^\circ\text{C}, I_F = 11A$  |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 3.4  | 5.1  | $\mu C$ | $di/dt = 100A/\mu s$ ⓄⓄ  |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_G + L_D$ ) |      |      |         |  |



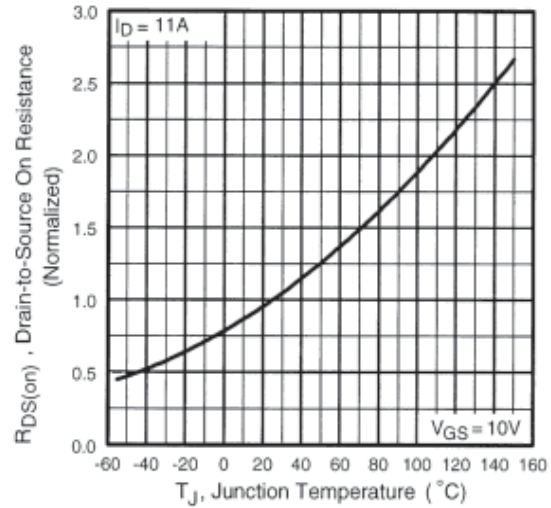
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



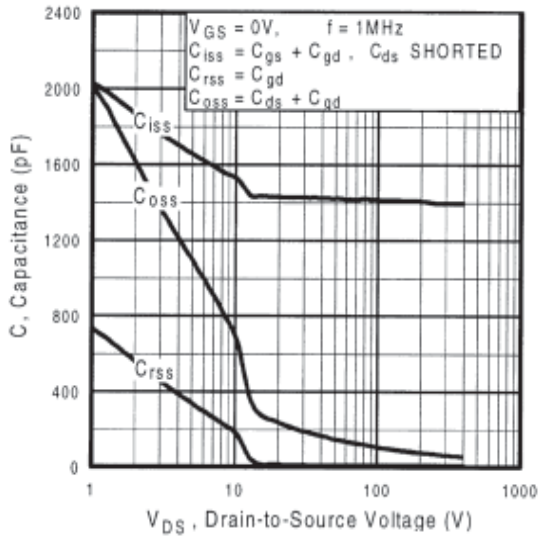
**Fig 3.** Typical Transfer Characteristics



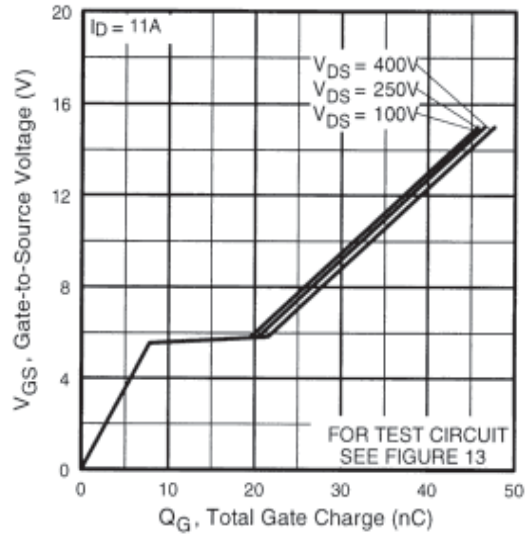
**Fig 4.** Normalized On-Resistance Vs. Temperature

# IRFS11N50APbF

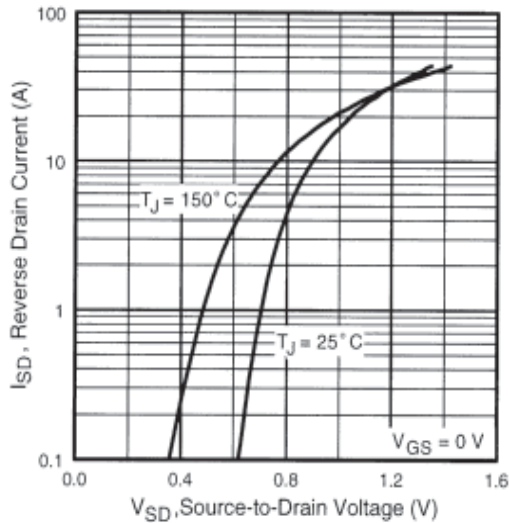
International  
**IR** Rectifier



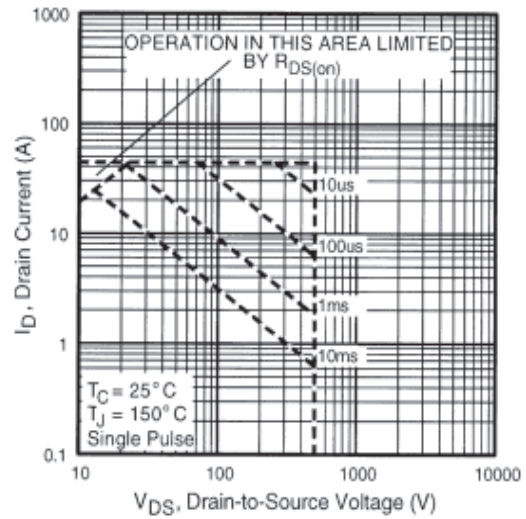
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



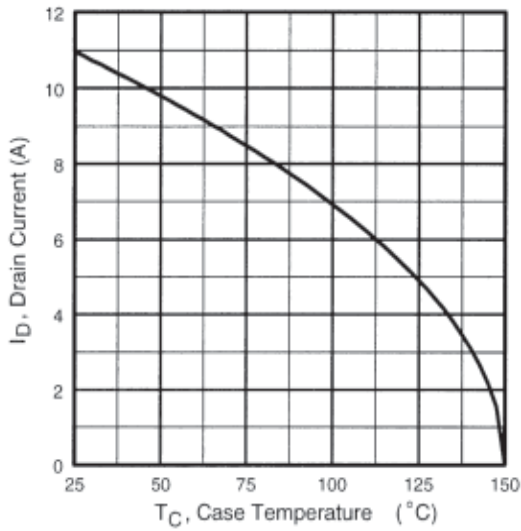
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



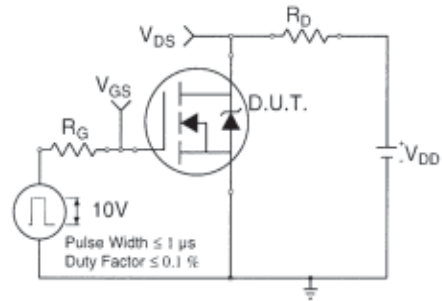
**Fig 7.** Typical Source-Drain Diode Forward Voltage



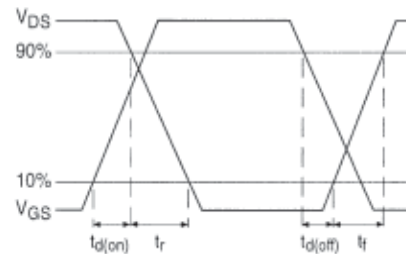
**Fig 8.** Maximum Safe Operating Area



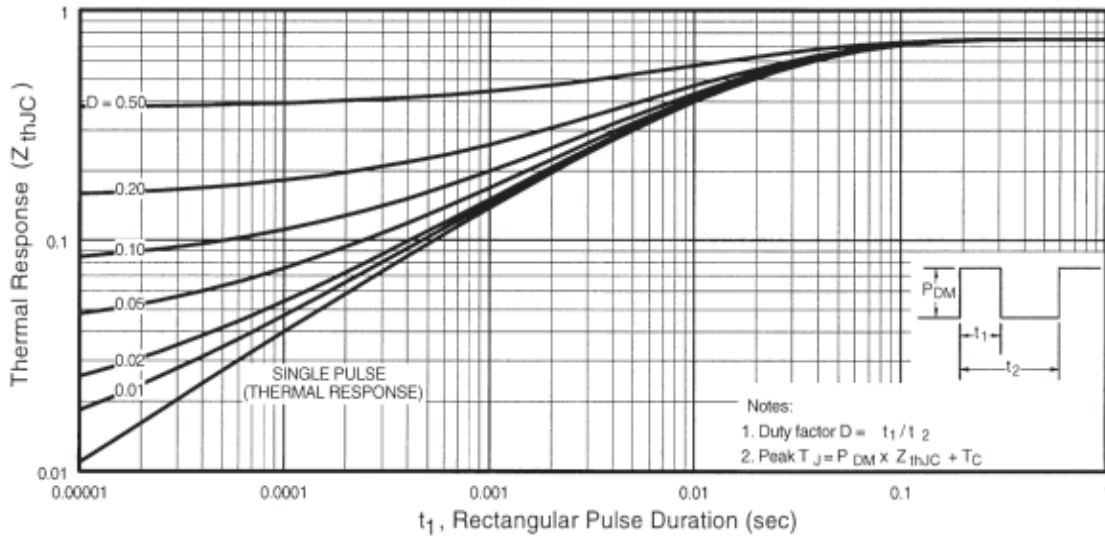
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms

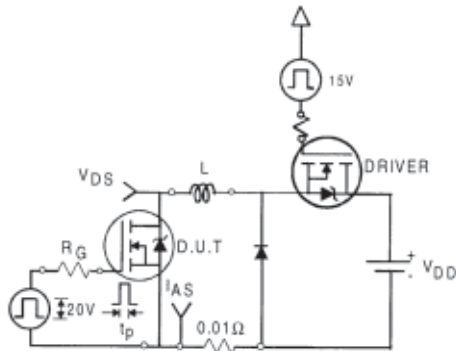


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

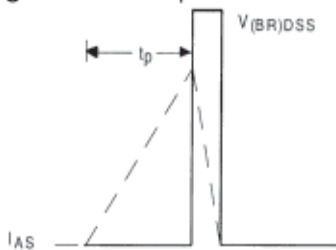


# IRFS11N50APbF

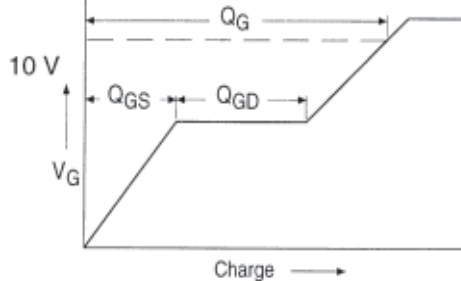
International  
**IR** Rectifier



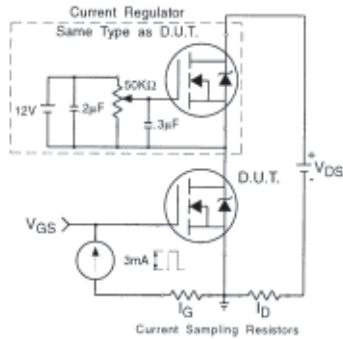
**Fig 12a.** Unclamped Inductive Test Circuit



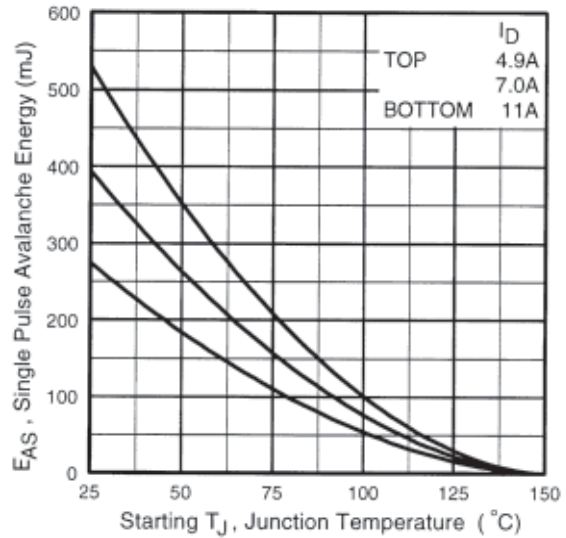
**Fig 12b.** Unclamped Inductive Waveforms



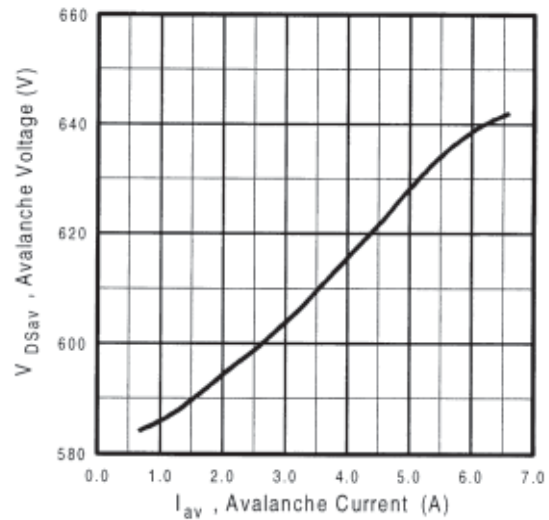
**Fig 13a.** Basic Gate Charge Waveform



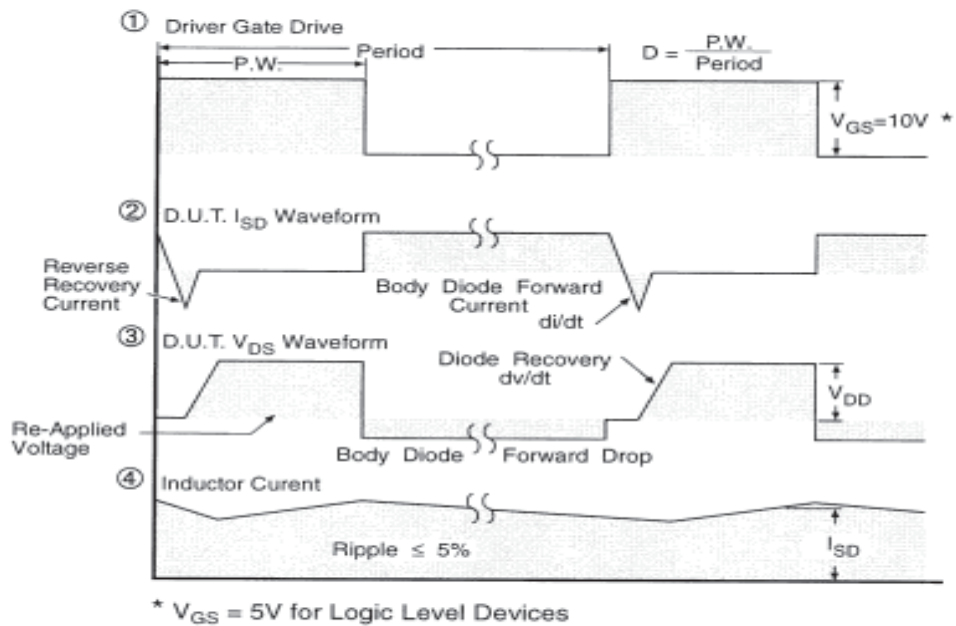
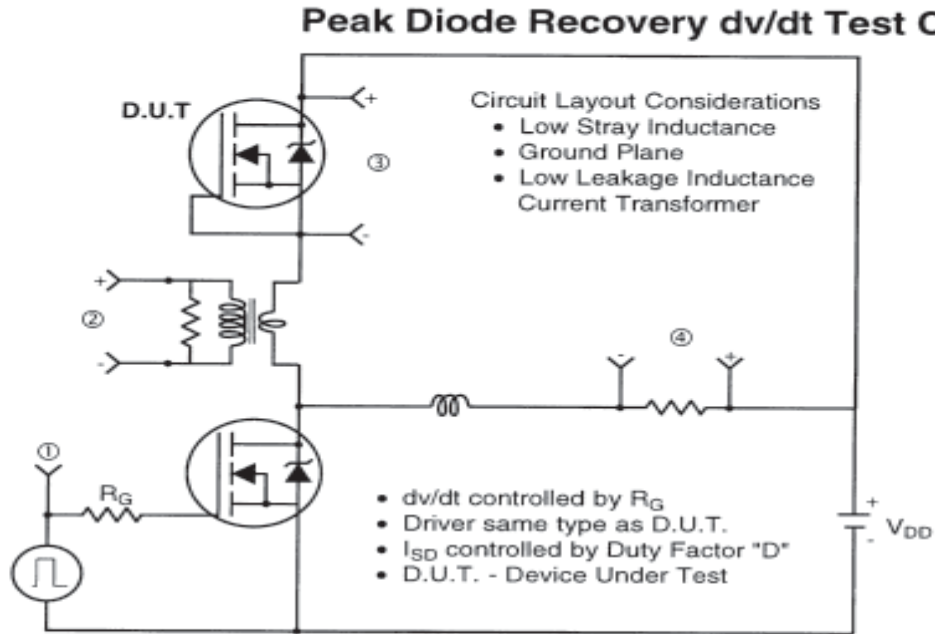
**Fig 13b.** Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 12d.** Typical Drain-to-Source Voltage Vs. Avalanche Current

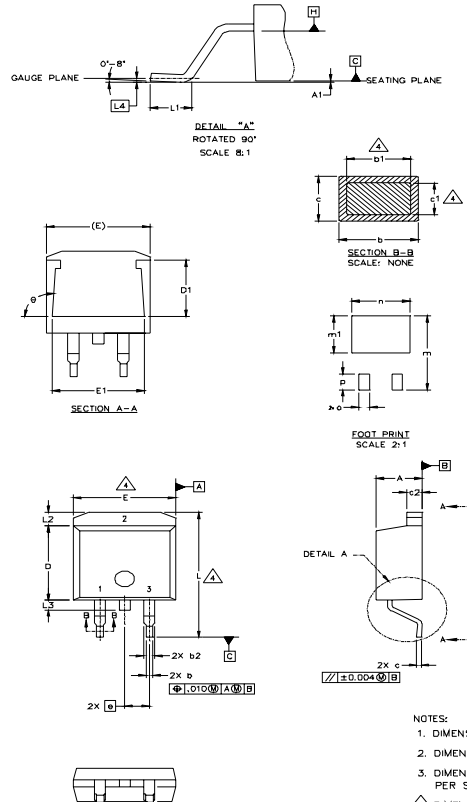


**Fig 14.** For N-Channel HEXFETS

# IRFS11N50APbF



## D<sup>2</sup>Pak Package Outline



| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 | 4     |
| A1     |             | 0.127 | .005     |      |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 |       |
| b2     | 1.14        | 1.40  | .045     | .055 | 4     |
| c      | 0.43        | 0.63  | .017     | .025 |       |
| c1     | 0.38        | 0.74  | .015     | .029 |       |
| c2     | 1.14        | 1.40  | .045     | .055 |       |
| D      | 8.51        | 9.65  | .335     | .380 | 3     |
| D1     | 5.33        |       | .210     |      | 3     |
| E      | 9.65        | 10.67 | .380     | .420 |       |
| E1     | 6.22        |       | .245     |      |       |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| L      | 14.61       | 15.88 | .575     | .625 |       |
| L1     | 1.78        | 2.79  | .070     | .110 |       |
| L2     |             | 1.65  |          | .065 |       |
| L3     | 1.27        | 1.78  | .050     | .070 |       |
| L4     | 0.25 BSC    |       | .010 BSC |      |       |
| m      | 17.78       |       | .700     |      |       |
| m1     | 8.89        |       | .350     |      |       |
| n      | 11.43       |       | .450     |      |       |
| o      | 2.08        |       | .082     |      |       |
| p      | 3.81        |       | .150     |      |       |
| θ      | 90°         | 93°   | 90°      | 93°  |       |

**LEAD ASSIGNMENTS**

|               |                      |               |
|---------------|----------------------|---------------|
| <b>HEXFET</b> | <b>IGBTs, CoPACK</b> | <b>DIODES</b> |
| 1.- GATE      | 1.- GATE             | 1.- ANODE *   |
| 2.- DRAIN     | 2.- COLLECTOR        | 2.- CATHODE   |
| 3.- SOURCE    | 3.- EMITTER          | 3.- ANODE     |

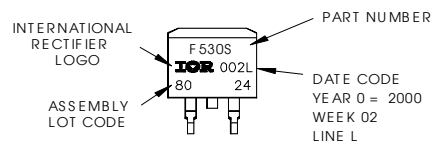
\* PART DEPENDENT.

- NOTES:
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
  - DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
  - DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
  - DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
  - CONTROLLING DIMENSION: INCH.

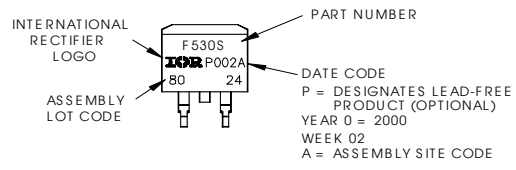
## D<sup>2</sup>Pak Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024 ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead-Free"



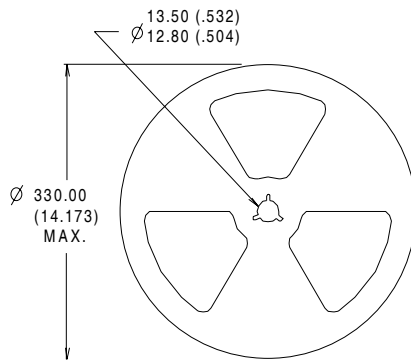
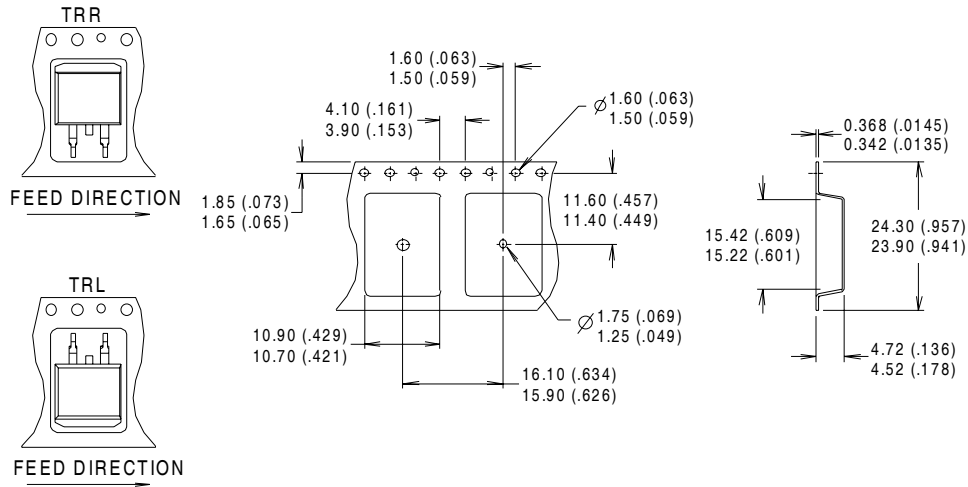
## OR



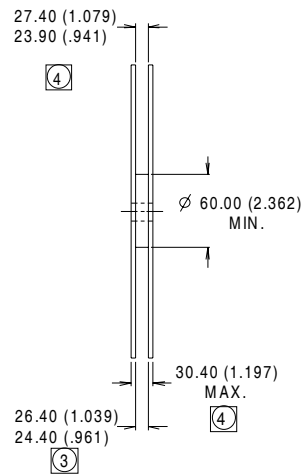


## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
1. COMFORMS TO EIA-418.
  2. CONTROLLING DIMENSION: MILLIMETER.
  - ③ DIMENSION MEASURED @ HUB.
  - ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.



Data and specifications subject to change without notice.